


<b>Search Notes</b>  	<b>Application/Control No.</b>  10045586	<b>Applicant(s)/Patent Under Reexamination</b>  MITCHELL ET AL.
	<b>Examiner</b>  Jean M Corrielus	<b>Art Unit</b>  2162

SEARCHED			
Class	Subclass	Date	Examiner
707	2, 10, 102, 203	2/11/08	JMC
717	227, 229	2/11/08	JMC

SEARCH NOTES		
Search Notes	Date	Examiner
NPL, ACM, IEEE, WEST	2/11/08	JMC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
707	203	2/11/08	JMC
715	227, 229	2/11/08	JMC